

TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (U-MOS )

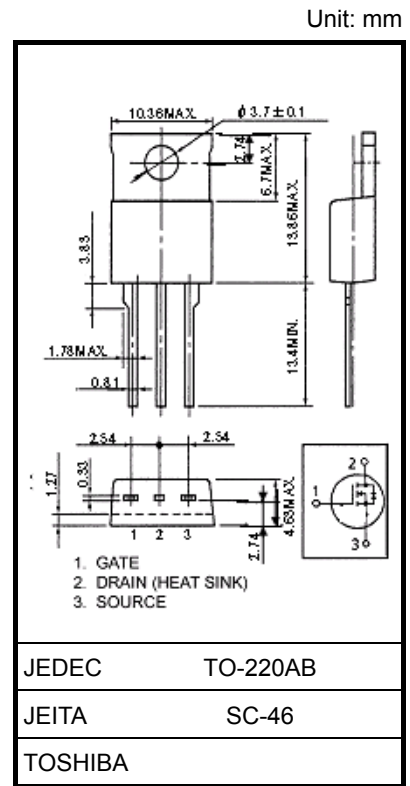
# TK80E08K3

■ E-Bike/UPS/Inverter

- Low drain-source ON resistance :  $R_{DS(ON)} = 7.5 \text{ m}\Omega$  (typ.)
- High forward transfer admittance :  $|Y_{fs}| = 135 \text{ S}$  (typ.)
- Low leakage current :  $I_{DSS} = 10 \text{ }\mu\text{A}$  (max) ( $V_{DS} = 75 \text{ V}$ )
- Enhancement mode :  $V_{th} = 2.0\sim 4.0 \text{ V}$  ( $V_{DS} = 10 \text{ V}$ ,  $I_D = 1 \text{ mA}$ )

**Absolute Maximum Ratings (Ta = 25°C)**

Characteristics S	ymbol	Rating	Unit
Drain-source voltage	$V_{DSS}$ 75		V
Drain-gate voltage ( $R_{GS} = 20 \text{ k}\Omega$ ) V	DGR 75		V
Gate-source voltage	$V_{GSS} \pm 20$		V
Drain current	DC (Note 1)	$I_D$ 80	A
	DC (Note 1,4)	$I_D$ 70	A
	Pulse (Note 1)	$I_{DP}$ 240	A
Drain power dissipation ( $T_c = 25^\circ\text{C}$ )	$P_D$ 200		W
Single pulse avalanche energy (Note 2)	$E_{AS}$ 107		mJ
Avalanche current	$I_{AR}$ 40		A
Repetitive avalanche energy (Note 3)	$E_{AR}$ 20		mJ
Peak diode recovery dv/dt (Note 5)	dv/dt	12	V/ns
Channel temperature (Note 4)	$T_{ch}$ 175		°C
Storage temperature range (Note 4)	$T_{stg}$	-55~175	°C



Weight: 1.9 g (typ.)

Note :Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc). Thermal Characteristics

Characteristics S	ymbol	Max	Unit
Thermal resistance, channel to case	$R_{th(ch-c)}$	0.75	°C / W
Thermal resistance, channel to ambient	$R_{th(ch-a)}$	83.3	°C / W

- Note 1: Ensure that the channel temperature does not exceed 175°C.
- Note 2:  $V_{DD} = 25 \text{ V}$ ,  $T_{ch} = 25^\circ\text{C}$  (initial),  $L = 100 \text{ }\mu\text{H}$ ,  $R_G = 25 \text{ }\Omega$ ,  $I_{AR} = 40\text{A}$
- Note 3: Repetitive rating: pulse width limited by maximum channel temperature
- Note 4:  $T_c=100$
- Note 5:  $I_{DR} = 80\text{A}$ ,  $di/dt = 160\text{A}/\mu\text{s}$ ,  $T_{ch} = T_{ch \text{ max}}$ .

This transistor is an electrostatic-sensitive device. Please handle with caution.

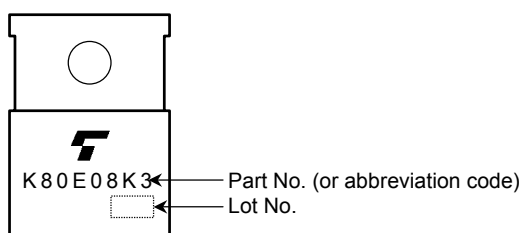
### Electrical Characteristics (Ta = 25°C)

Characteristics S		ymbol	Test Condition	Min	Typ.	Max	Unit
Gate leakage current		I <sub>GSS</sub>	V <sub>GS</sub> = ±20 V, V <sub>DS</sub> = 0 V	—	—	±1	μA
Drain cut-off current		I <sub>DSS</sub>	V <sub>DS</sub> = 75 V, V <sub>GS</sub> = 0 V	—	—	10	μA
Drain-source breakdown voltage		V <sub>(BR) DSS</sub>	I <sub>D</sub> = 10 mA, V <sub>GS</sub> = 0 V	75	—	—	V
		V <sub>(BR) DSX</sub>	I <sub>D</sub> = 10 mA, V <sub>GS</sub> = -20 V	45	—	—	V
Gate threshold voltage		V <sub>th</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA	2.0	—	4.0	V
Drain-source ON resistance		R <sub>DS (ON)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 40 A	—	7.5	9.0	mΩ
Forward transfer admittance		Y <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 40 A	67	135	—	S
Input capacitance		C <sub>iss</sub> —	V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 0 V, f = 1 MHz	—	3600	—	pF
Reverse transfer capacitance		C <sub>rss</sub> —		—	350	—	
Output capacitance		C <sub>oss</sub>		—	500	—	
Switching time	Rise time	t <sub>r</sub> —		—	95	—	ns
	Turn-on time	t <sub>on</sub> —		—	135	—	
	Fall time	t <sub>f</sub> —		—	85	—	
	Turn-off time	t <sub>off</sub>		Duty ≤ 1%, t <sub>w</sub> = 10 μs	—	220	
Total gate charge (Gate-source plus gate-drain)		Q <sub>g</sub> —	V <sub>DD</sub> ≈ 75 V, V <sub>GS</sub> = 10 V, I <sub>D</sub> = 80 A	—	75	—	nC
Gate-source charge		Q <sub>gs</sub> —		—	44	—	
Gate-drain ("miller") charge		Q <sub>gd</sub>		—	31	—	

### Source-Drain Ratings and Characteristics (Ta = 25°C)

Characteristics S		ymbol	Test Condition	Min	Typ.	Max	Unit
Continuous drain reverse current (Note 1)		I <sub>DR</sub>	—	—	—	80	A
Pulse drain reverse current (Note 1)		I <sub>DRP</sub>	—	—	—	240	A
Forward voltage (diode)		V <sub>DSF</sub>	I <sub>DR</sub> = 80 A, V <sub>GS</sub> = 0 V	—	—	-1.5	V
Reverse recovery time		t <sub>rr</sub>	I <sub>DR</sub> = 80 A, V <sub>GS</sub> = 0 V	—	45	—	ns
Reverse recovery charge		Q <sub>rr</sub>	dI <sub>DR</sub> / dt = 100 A / μs	—	72	—	μC

### Marking



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